



**AO6602**

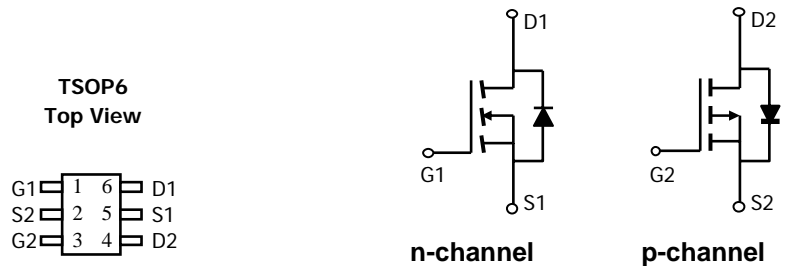
**Complementary Enhancement Mode Field Effect Transistor**

**General Description**

The AO6602 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs form a high-speed power inverter, suitable for a multitude of applications. *Standard Product AO6602 is Pb-free (meets ROHS & Sony 259 specifications). AO6602L is a Green Product ordering option. AO6602 and AO6602L are electrically identical.*

**Features**

|  |                           |
|--|---------------------------|
| n-channel  | p-channel                 |
| $V_{DS} (V) = 30V$   | -30V                      |
| $I_D = 3.1A (V_{GS} = 10V)$                                  | -2.7A ( $V_{GS} = -10V$ ) |
| $R_{DS(ON)}$   |                           |
| < $75m\Omega (V_{GS} = 10V) < 100m\Omega (V_{GS} = -10V)$    |                           |
| < $115m\Omega (V_{GS} = 4.5V) < 180m\Omega (V_{GS} = -4.5V)$ |                           |



**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

| Parameter                              | Symbol           | Max n-channel | Max p-channel | Units      |
|--|------------------|---------------|---------------|------------|
| Drain-Source Voltage                   | $V_{DS}$         | 30            | -30           | V          |
| Gate-Source Voltage                    | $V_{GS}$         | $\pm 20$      | $\pm 20$      | V          |
| Continuous Drain Current <sup>A</sup>  | $T_A=25^\circ C$ | 3.1           | -2.7          | A          |
|  | $T_A=70^\circ C$ | 2.4           | -2.1          |            |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$         | 12            | -12           |            |
| Power Dissipation                      | $T_A=25^\circ C$ | 1.15          | 1.15          | W          |
|  | $T_A=70^\circ C$ | 0.73          | 0.73          |            |
| Junction and Storage Temperature Range | $T_J, T_{STG}$   | -55 to 150    | -55 to 150    | $^\circ C$ |

**Thermal Characteristics: n-channel and p-channel**

| Parameter                                | Symbol          | Typ | Max | Units        |
|--|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 78  | 110 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | 106 | 150 | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 64  | 80  | $^\circ C/W$ |

N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max    | Units            |
|-----------------------------|---------------------------------------|--|-----|------|--------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |        |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$  | 30  |      |        | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=24\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |     |      | 1<br>5 | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                       |     |      | 100    | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$   | 1   | 1.9  | 3      | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$   | 10  |      |        | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=3.1\text{A}$  |     | 54   | 75     | $\text{m}\Omega$ |
|                             |                                       | $T_J=125^\circ\text{C}$  |     | 78   |        |                  |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=2\text{A}$   |     | 88   | 115    | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=3.1\text{A}$   |     | 4.5  |        | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$  |     | 0.79 | 1      | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |      | 2.5    | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |        |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                         |     | 200  | 240    | $\text{pF}$      |
| $C_{oss}$                   | Output Capacitance                    |  |     | 40   |        | $\text{pF}$      |
| $C_{riss}$                  | Reverse Transfer Capacitance          |  |     | 20   |        | $\text{pF}$      |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 2.3  | 3      | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |        |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=3.1\text{A}$                      |     | 6.5  | 8.5    | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 3.1  | 4      | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 1.2  |        | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 1.6  |        | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=4.7\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 3.3  |        | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 2.5  |        | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |  |     | 13.2 |        | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 1.7  |        | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=3.1\text{A}$ , $di/dt=100\text{A}/\mu\text{s}$                                |     | 9.4  | 12     | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=3.1\text{A}$ , $di/dt=100\text{A}/\mu\text{s}$                                |     | 3.5  |        | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t_s \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 $\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

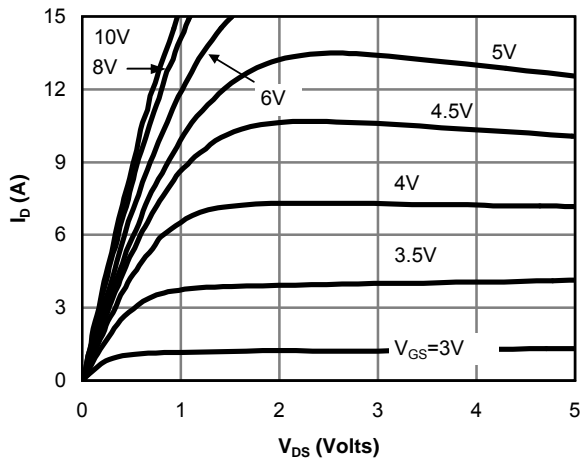


Fig 1: On-Region Characteristics

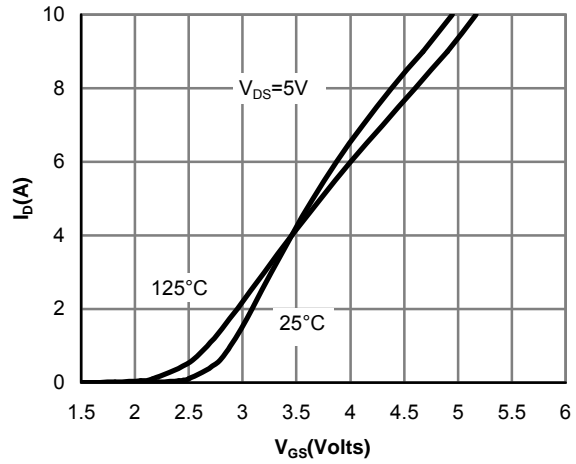


Figure 2: Transfer Characteristics

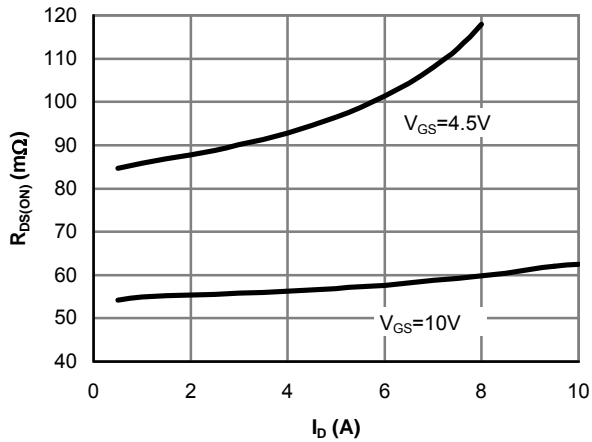


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

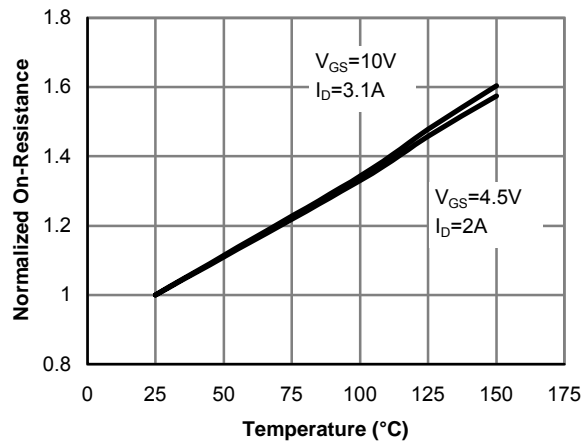


Figure 4: On-Resistance vs. Junction Temperature

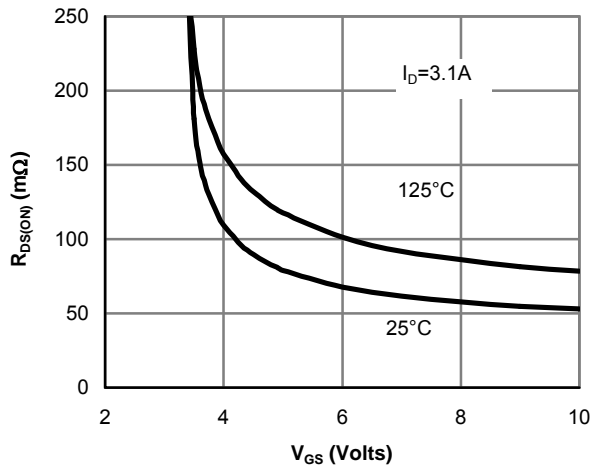


Figure 5: On-Resistance vs. Gate-Source Voltage

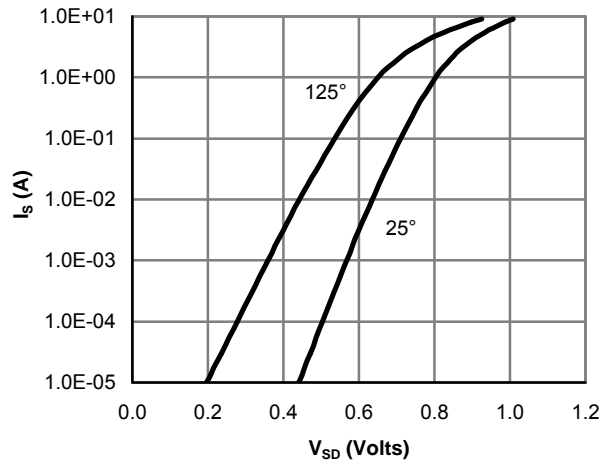


Figure 6: Body-Diode Characteristics

N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

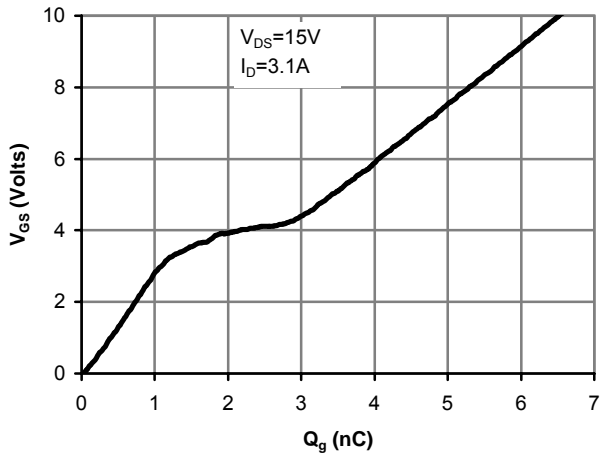


Figure 7: Gate-Charge Characteristics

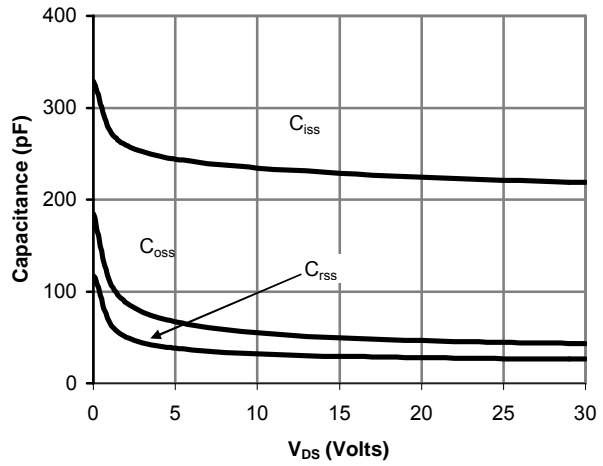


Figure 8: Capacitance Characteristics

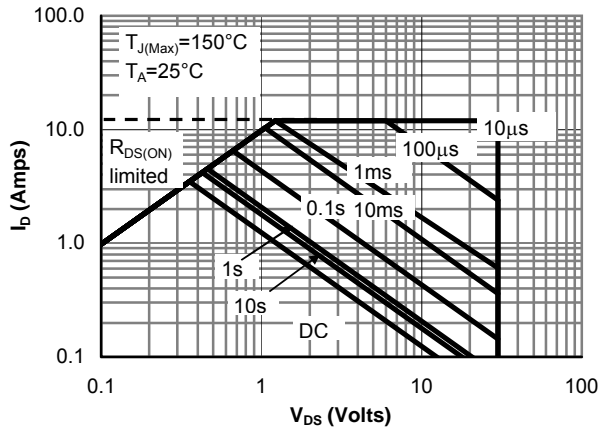


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

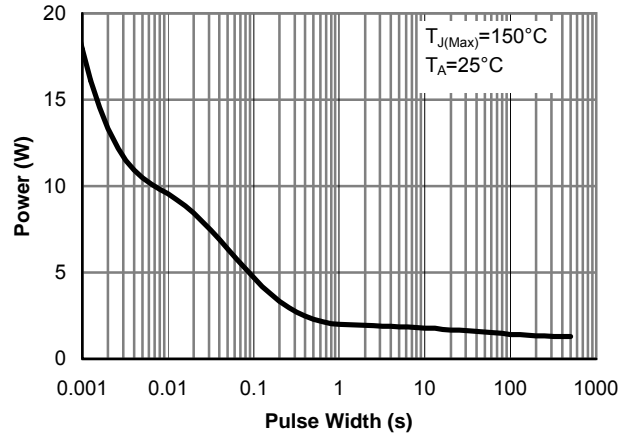


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

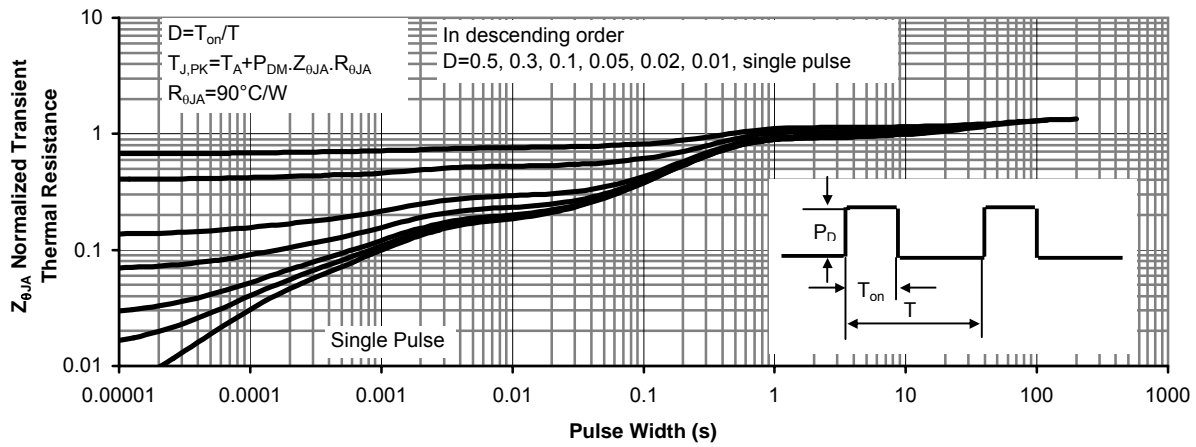


Figure 11: Normalized Maximum Transient Thermal Impedance

P-Channel Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min | Typ       | Max      | Units |
|-----------------------------|---------------------------------------|---|-----|-----------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |           |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V                           | -30 |           |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C    |     |           | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                            |     |           | ±100     | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA             | -1  | -1.9      | -3       | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-5V                          | -5  |           |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-10V, I <sub>D</sub> =-2.7A<br>T <sub>J</sub> =125°C |     | 77<br>110 | 100      | mΩ    |
|                             |                                       | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2A                           |     | 130       | 180      | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-2.7A                           |     | 4.1       |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V                              |     | -0.81     | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |     |           | -2       | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |           |          |       |
| C <sub>iss</sub>            | Input Capacitance                     |   |     | 260       | 312      | pF    |
| C <sub>oss</sub>            | Output Capacitance                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz                    |     | 55        |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   |     | 44        |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                      |     | 4.3       | 5        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |           |          |       |
| Q <sub>g(10)</sub>          | Total Gate Charge(10V)                |   |     | 5.8       | 7        | nC    |
| Q <sub>g(4.5)</sub>         | Total Gate Charge(4.5V)               | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-2.7A   |     | 3         | 4        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |     | 0.78      |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |     | 1.6       |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     |   |     | 7         |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =5.6Ω,   |     | 6         |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    | R <sub>GEN</sub> =3Ω  |     | 15        |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |     | 7.5       |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-2.7A, dI/dt=100A/μs                                  |     | 12.5      | 15       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-2.7A, dI/dt=100A/μs                                  |     | 5.5       |          | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any a given application depends on the user's specific board design. The current rating is based on the ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

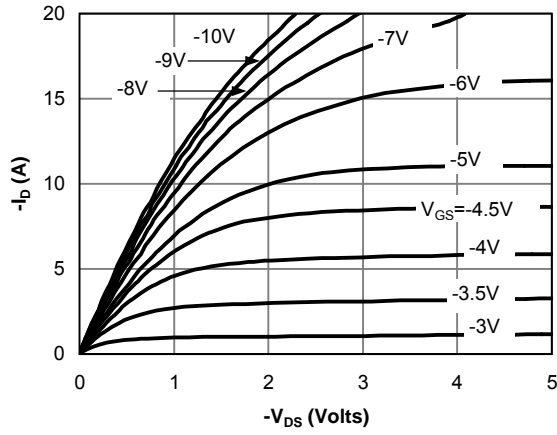


Fig 1: On-Region Characteristics

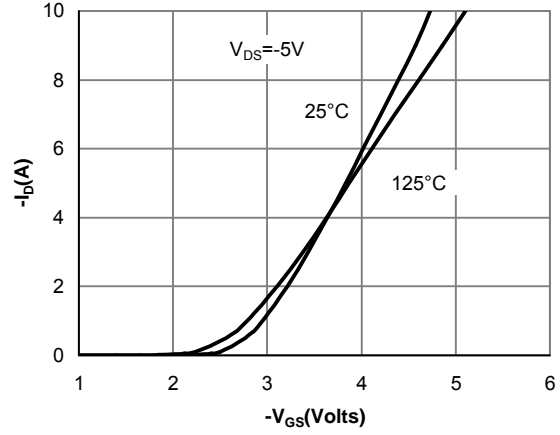


Figure 2: Transfer Characteristics

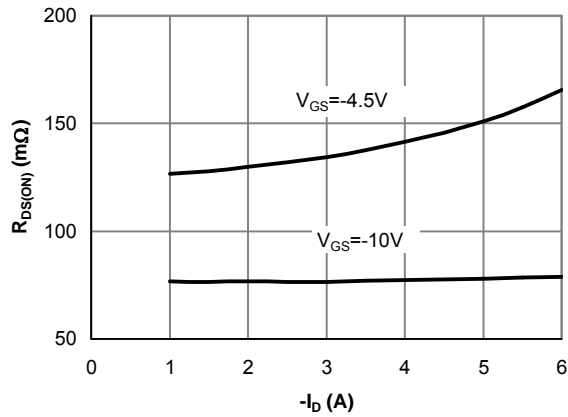


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

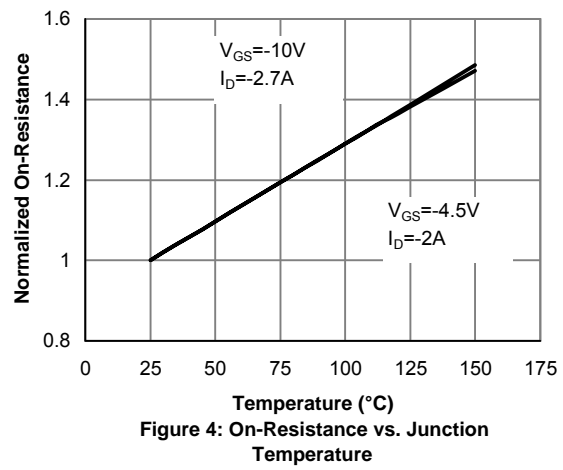


Figure 4: On-Resistance vs. Junction Temperature

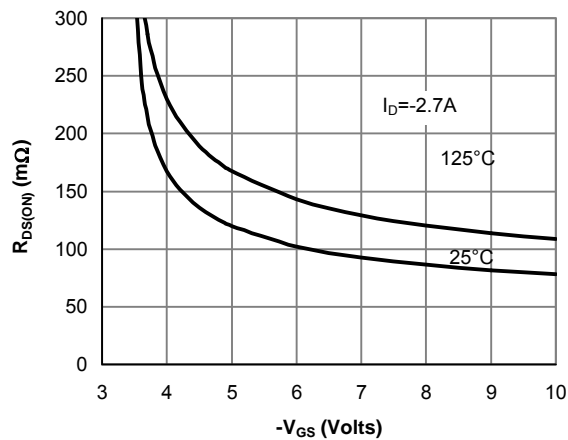


Figure 5: On-Resistance vs. Gate-Source Voltage

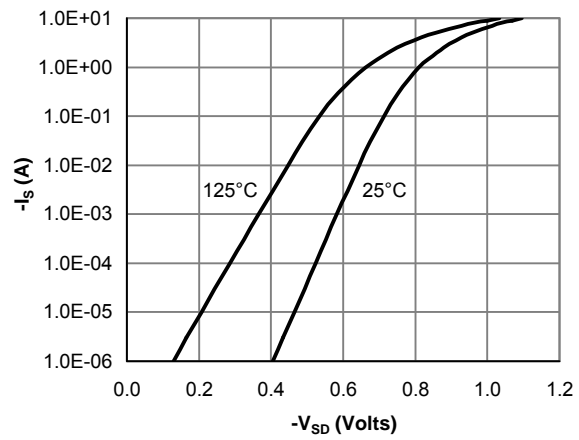


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

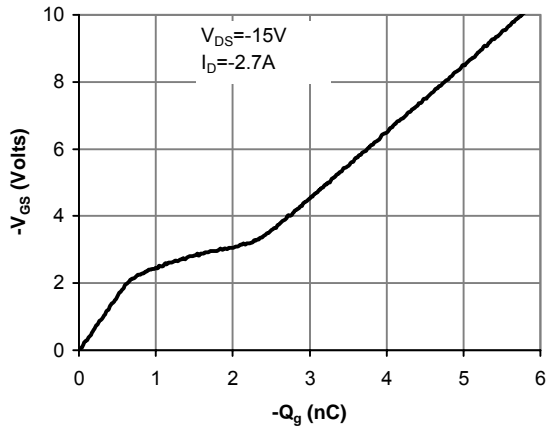


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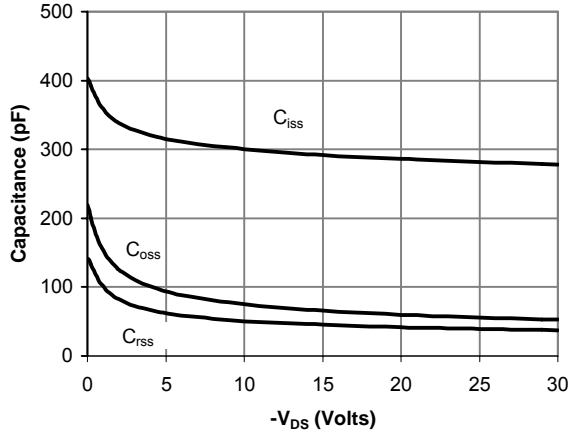


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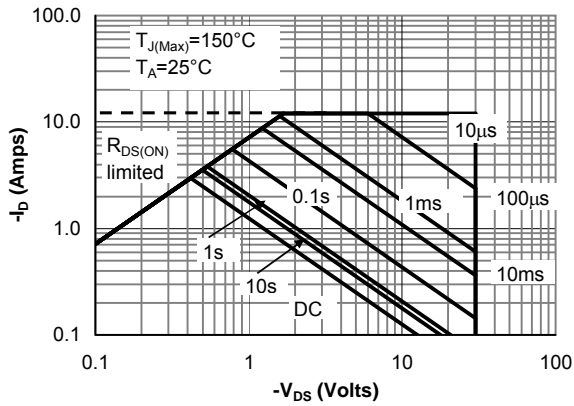


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

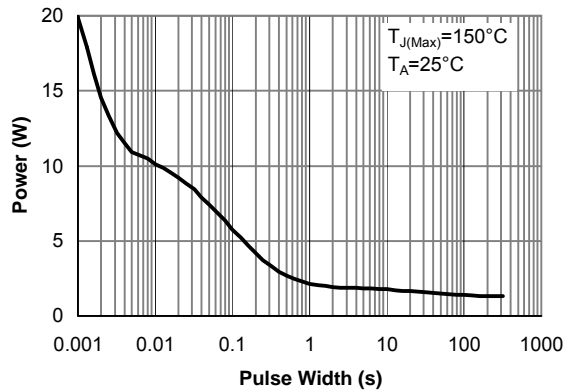


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

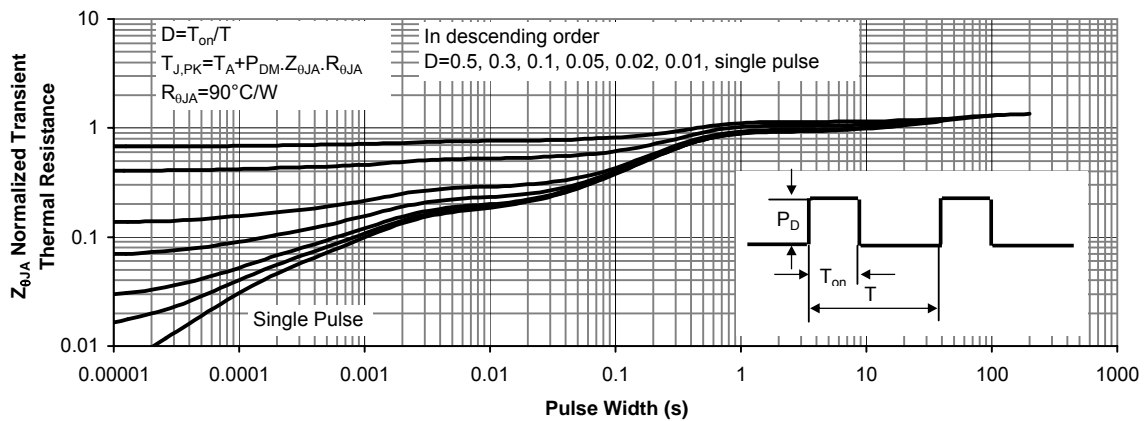


Figure 11: Normalized Maximum Transient Thermal Impedance